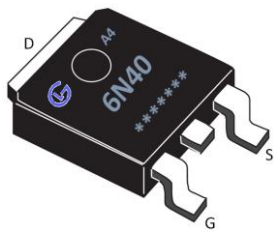
GL Silicon N-Channel Power MOSFET

V_{DSS}	400	V
I_D	6	A
P_D (T_C=25℃)	75	W
$R_{DS(ON)type}$	0.75	Ω

TO-252



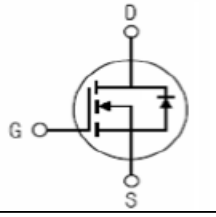
General Description :

GL6N60A4 the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-252, which accords with the RoHS standard.

Features :

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

Inner Equivalent Principium Chart



Applications :

- Power switch circuit of adaptor and charger.

Absolute (Tc= 25℃ unless otherwise specified) :

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	400	V
I_D	Continuous Drain Current	6.0	A
	Continuous Drain Current T_C=100 °C	4.2	A
I_{DM} [a1]	Pulsed Drain Current	36.0	A
V_{GS}	Gate-to-Source Voltage	±30	V
E_{AS} [a2]	Single Pulse Avalanche Energy	200	mJ
E_{AR} [a1]	Avalanche Energy ,Repetitive	26	mJ
I_{AR} [a1]	Avalanche Current	2.3	A
dv/dt [a3]	Peak Diode Recovery dv/dt	5.0	V/ns
P_D	Power Dissipation	75	W
	Derating Factor above 25°C	0.6	W/℃
T_J , T_{stg}	Operating Junction and Storage Temperature Range	150 , –55 to 150	℃
T_L	Maximum Temperature for Soldering	300	℃

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Electrical Characteristics (Tc= 25℃ unless otherwise specified) :

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	V_{GS}=0V, I_D=250μA	400	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	ID=250uA,Reference25℃	--	0.55	--	V/℃
I_{DSS}	Drain to Source Leakage Current	V_{DS}=400V,V_{GS}= 0V,T_a=25℃	--	--	1	μA
		V_{DS}=320V,V_{GS}=0V,T_a=125℃	--	--	250	
$I_{GSS(F)}$	Gate to Source Forward Leakage	V_{GS}=+30V	--	--	10	μA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	V_{GS}=-30V	--	--	-10	μA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	V_{GS}=10V,I_D=3.0A	--	0.75	1.0	Ω
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS}=V_{GS},I_D=250μA	2.0	3.0	4.0	V
Pulse width tp≤380μs,δ≤2%						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g_{fs}	Forward Transconductance	V_{DS}=15V,I_D=3A	--	4.5	--	S
C_{iss}	Input Capacitance	V_{GS}=0V , V_{DS}=25V f=1.0MHz	--	540	--	pF
C_{oss}	Output Capacitance		--	68	--	
C_{rss}	Reverse Transfer Capacitance		--	7.5	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	I_D=6.0A,V_{DD}=200V V_{GS}=10V,R_G=9.1Ω	--	9	--	ns
t_r	Rise Time		--	11	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	29	--	
t_f	Fall Time		--	16	--	
Q_g	Total Gate Charge	I_D=6.0A,V_{DD}=200V V_{GS}=10V	--	14	--	nC
Q_{gs}	Gate to Source Charge		--	3	--	
Q_{gd}	Gate to Drain (“Miller”)Charge		--	6.5	--	

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Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I_S	Continuous Source Current (Body Diode)		--	--	6	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	24	A
V_{SD}	Diode Forward Voltage	I_S=6.0A,V_{GS}=0V	--	--	1.5	V
t_{rr}	Reverse Recovery Time	I_S=6.0A,T_j = 25°C	--	388	--	ns
Q_{rr}	Reverse Recovery Charge	dI_F/dt=100A/us,V_{GS}=0V	--	1720	--	nC
Pulse width tp≤380μs,δ≤2%						

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case	1.67	℃/W
$R_{\theta JA}$	Junction-to-Ambient	62.5	℃/W

[a1] : Repetitive rating; pulse width limited by maximum junction temperature
[a2] : L=10.0mH, I_D=6.4A, Start T_J=25℃
[a3] : I_{SD} =6A,di/dt ≤100A/us,V_{DD}≤BV_{DS}, Start T_J=25℃

Test Circuit and Waveform

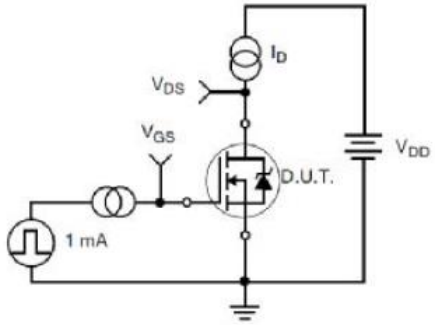

Figure 17. Gate Charge Test Circuit

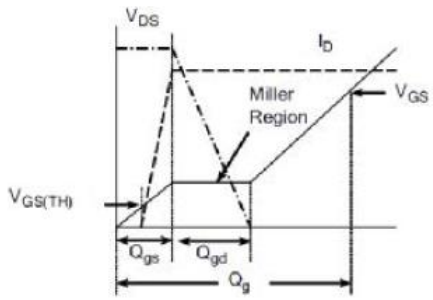

Figure 18. Gate Charge Waveform

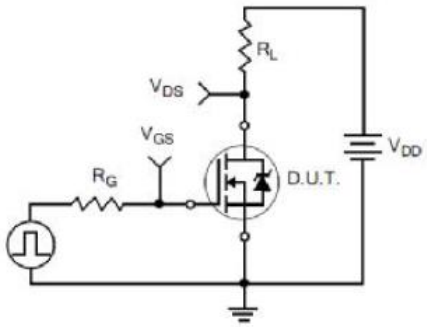

Figure 19. Resistive Switching Test Circuit

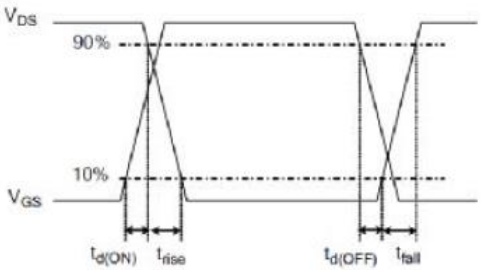

Figure 20. Resistive Switching Waveforms

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Characteristics Curve:

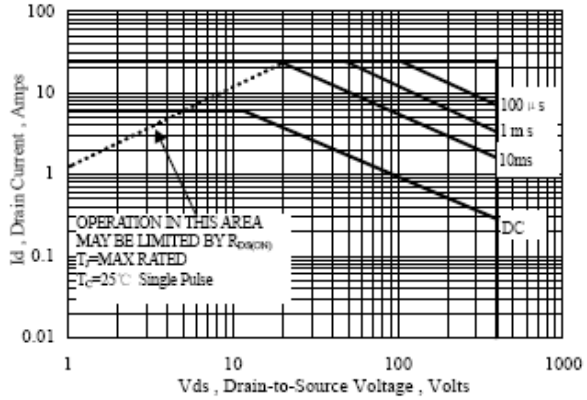

Figure 1 Maximum Forward Bias Safe Operating Area

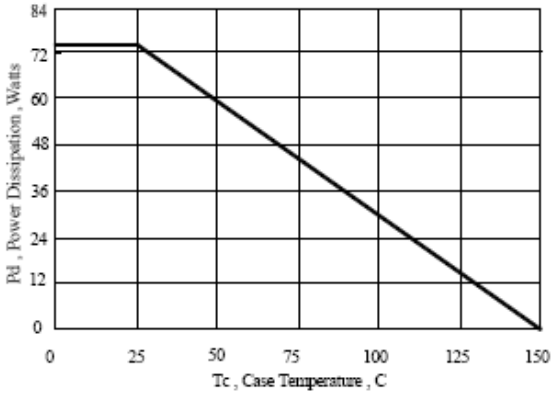

Figure 2 Maximum Power Dissipation vs Case Temperature

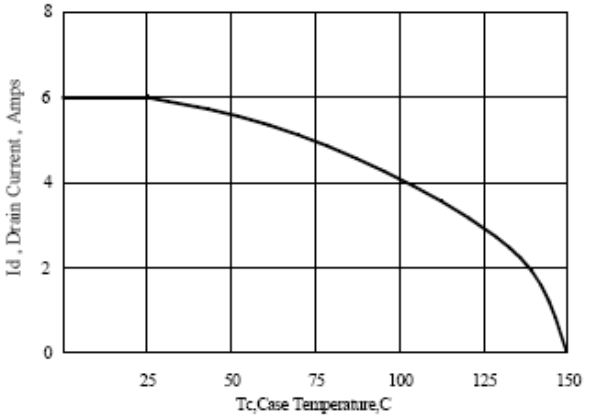

Figure 3 Maximum Continuous Drain Current vs Case Temperature

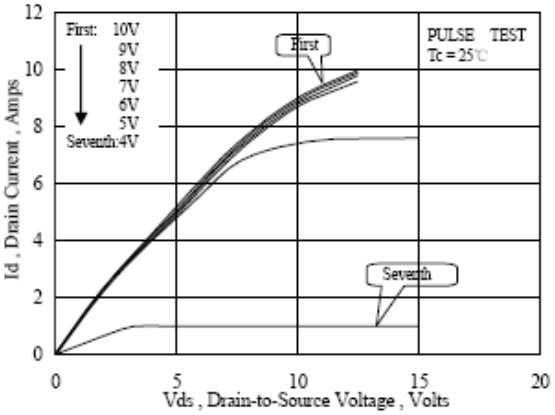

Figure 4 Typical Output Characteristics

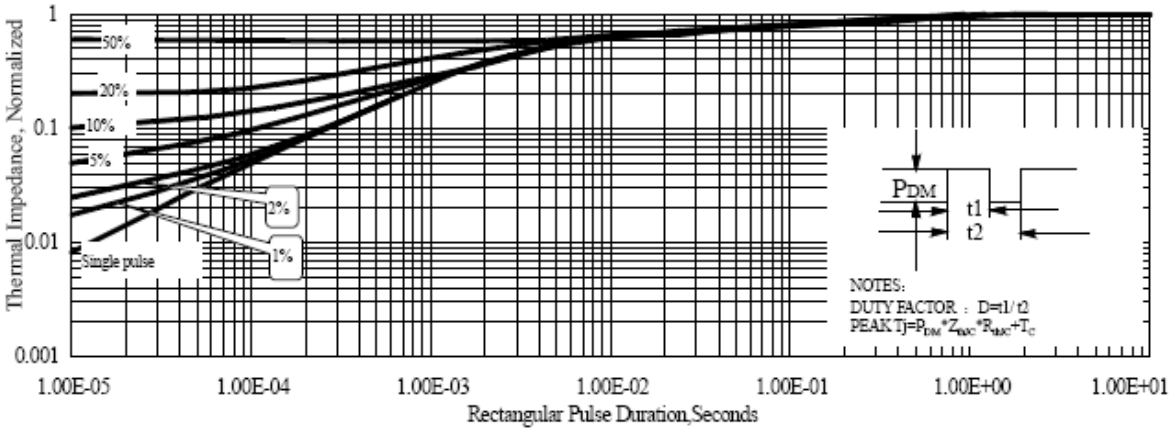

Figure 5 Maximum Effective Thermal Impendance , Junction to Case

GL Silicon N-Channel Power MOSFET

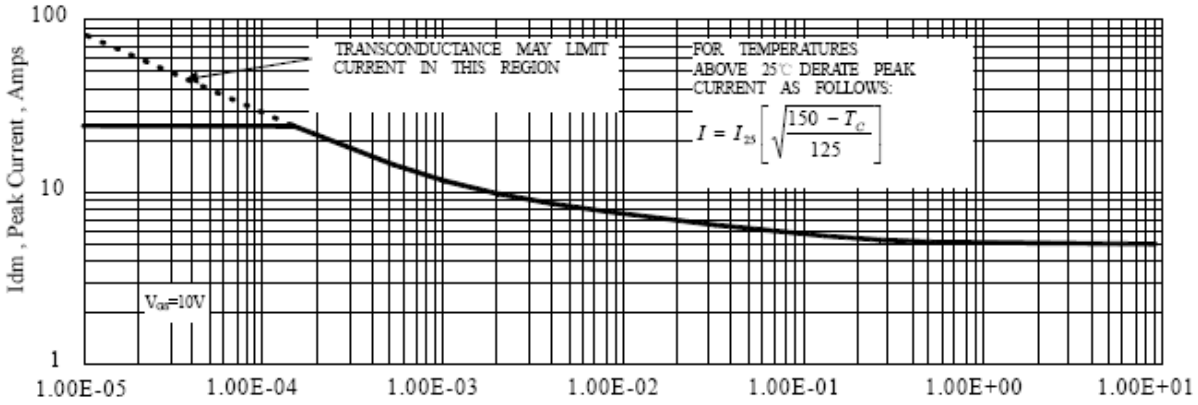

Figure 6 Maximum Peak Current Capability

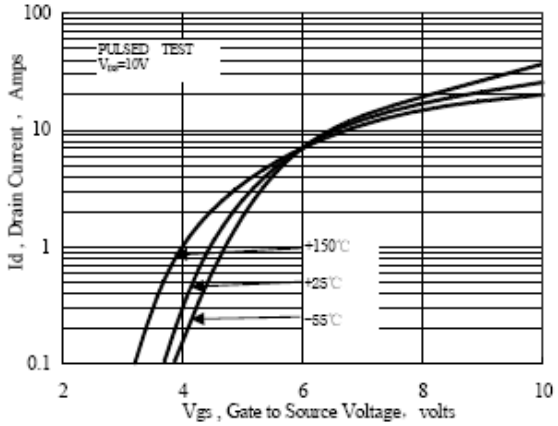

Figure 7 Typical Transfer Characteristics

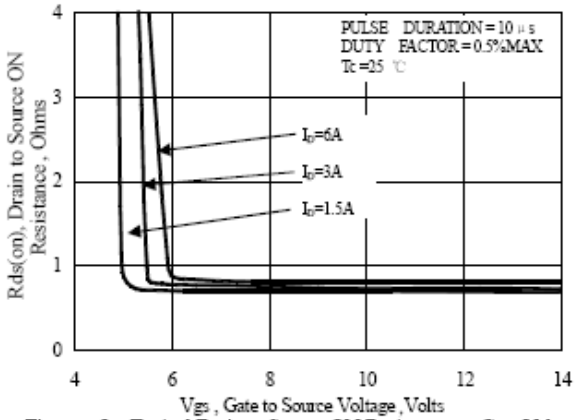

Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

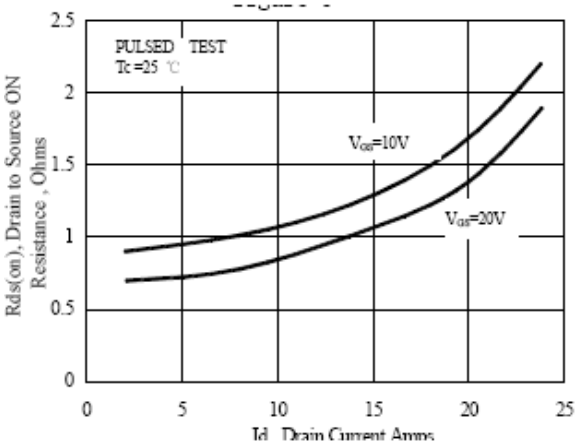

Figure 9 Typical Drain to Source ON Resistance vs Drain Current

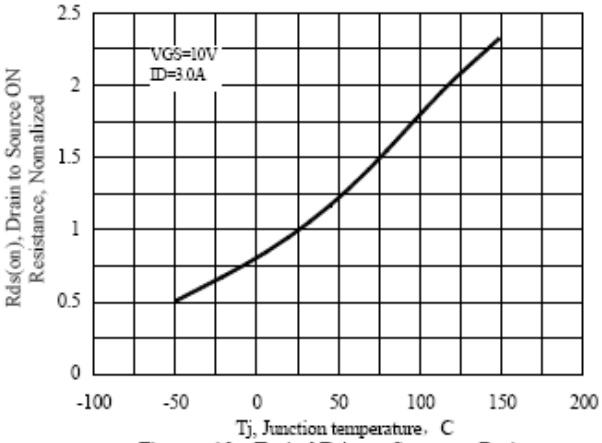

Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

GL Silicon N-Channel Power MOSFET

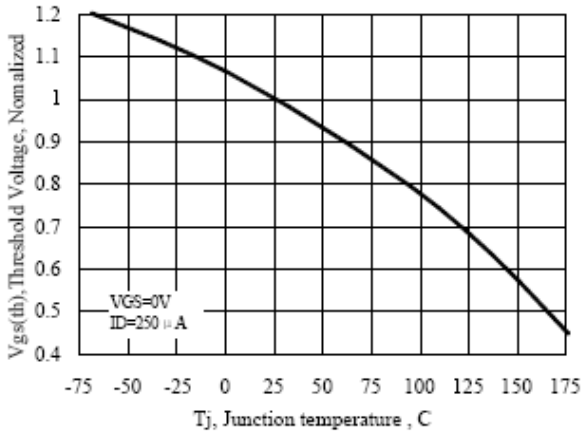

Figure 11 Typical Theshold Voltage vs Junction Temperature

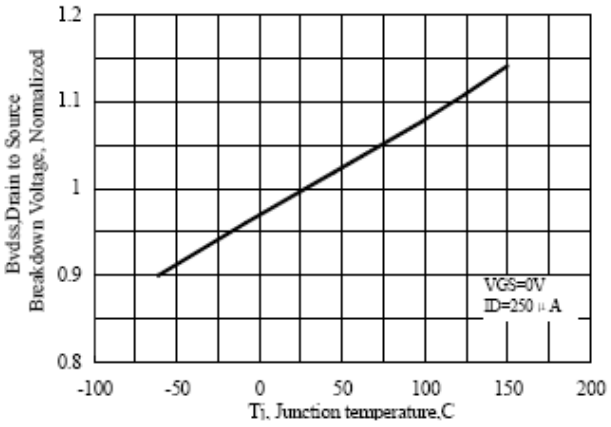

Figure 12 Typical Breakdown Voltage vs Junction Temperature

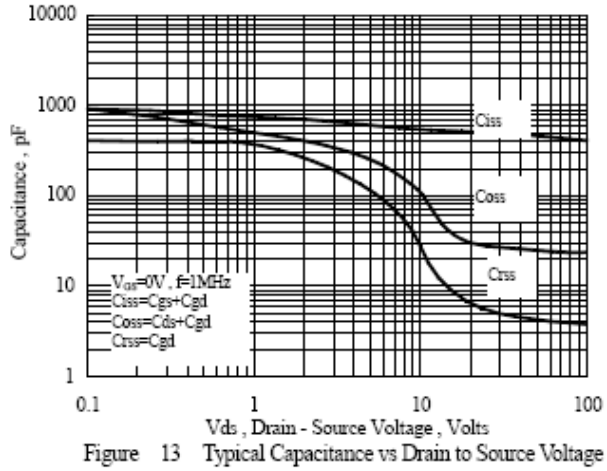

Figure 13 Typical Capacitance vs Drain to Source Voltage

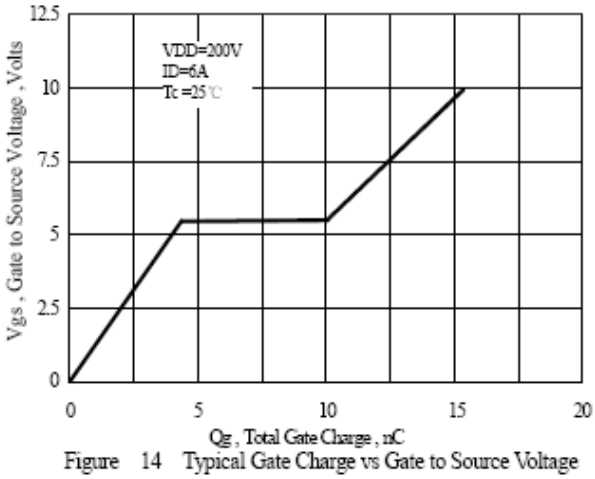

Figure 14 Typical Gate Charge vs Gate to Source Voltage

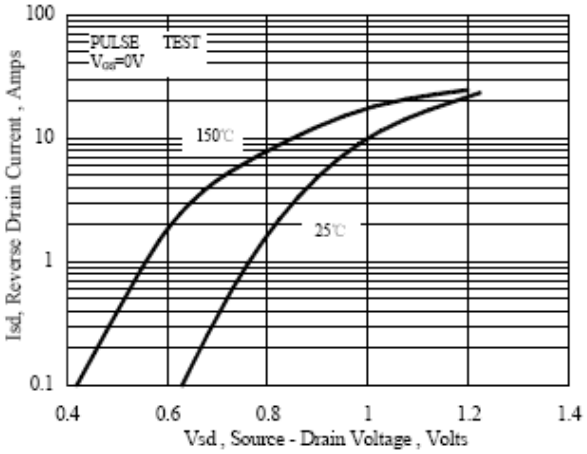

Figure 15 Typical Body Diode Transfer Characteristics

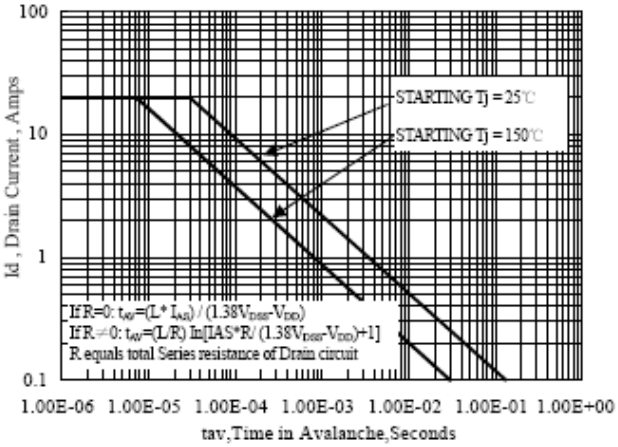

Figure 16 Unclamped Inductive Switching Capability

GL Silicon N-Channel Power MOSFET

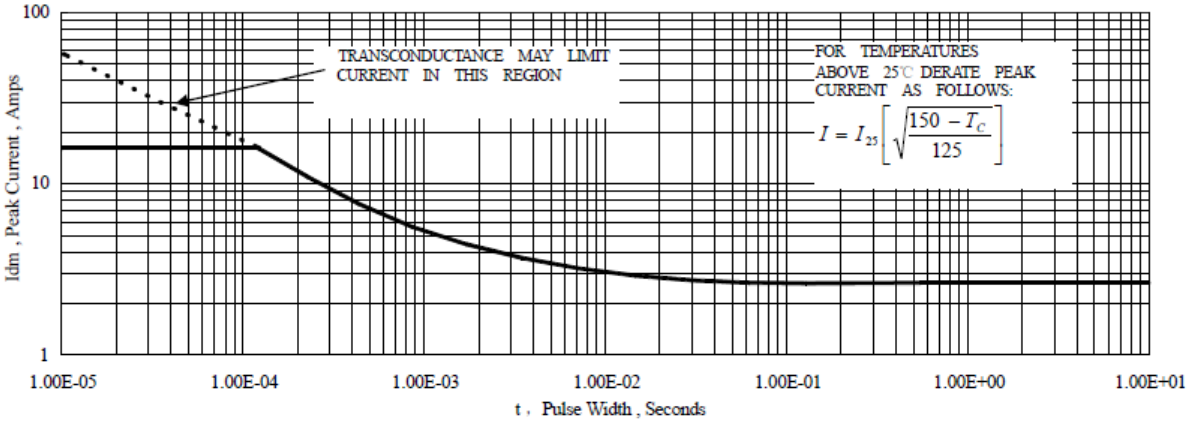

Figure 6 Maximum Peak Current Capability

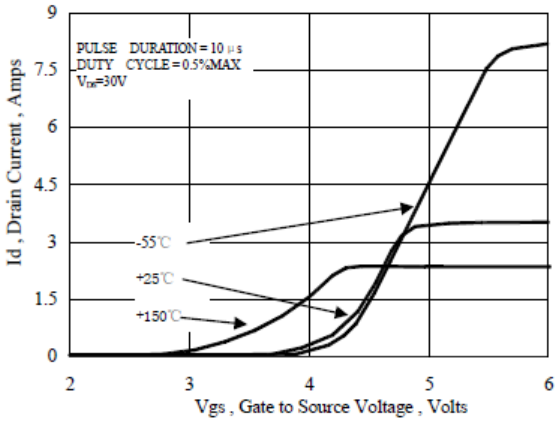

Figure 7 Typical Transfer Characteristics

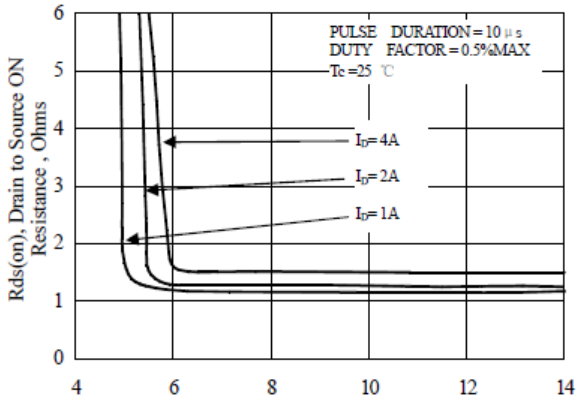

Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

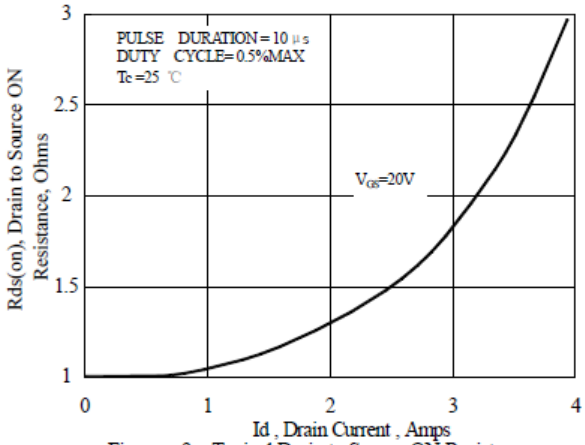

Figure 9 Typical Drain to Source ON Resistance vs Drain Current

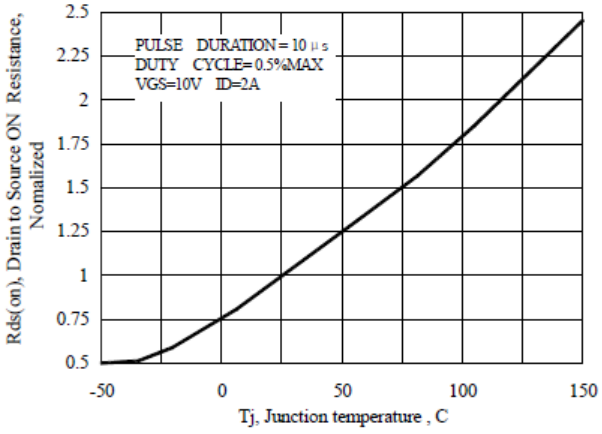

Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

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TEL : 13961734102 Mr.yuan